Unit

 $^{\circ}$ C



700V N-Channel MOSFET

General Features

- **Advanced Planar Process**
- $R_{DS(ON),typ.}$ =350 m Ω @ V_{GS} =10V
- Low Gate Charge Minimize Switching Loss
- Rugged Poly silicon Gate Structure

Absolute Maximum Ratings

Applications

- **BLDC Motor Driver**
- Electric Welder

Symbol

 T_{l}

 $\mathsf{T}_{\mathsf{PAK}}$

T_J& T_{STG}

High Efficiency SMPS

Ordering Information

Part Number	Package	Brand		
PTA26N70	TO-220F	ĭ		

Parameter

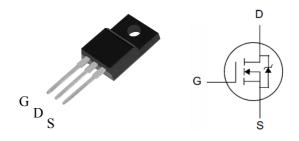
Leads at 0.063in (1.6mm) from Case for 10

Operating and Storage Temperature Range

seconds, Package Body for 10 seconds

(PK) Lead Free Package and Finish

BV _{DSS}	R _{DS(ON),typ.}	I _D
700V	$350 m\Omega$	26A



TO-220F Package

T_C=25 [°]C unless otherwise specified

PTA26N70

300

260

-55 to 150

- ,				
V _{DSS} Drain-to-Source Voltage		700	V	
V_{GSS}	Gate-to-Source Voltage	±30	v	
1	Continuous Drain Current	26		
I _D	Continuous Drain Current @ Tc=100℃	17	Α	
I_{DM}	Pulsed Drain Current at V _{GS} =10V ^[2,4]	104		
E _{AS} Single Pulse Avalanche Energy		1000	mJ	
dv/dt	Peak Diode Recovery dv/dt ^[3]	5.0	V/ns	
D	Power Dissipation	77	W	
P_D	Derating Factor above 25℃	0.61	W/°C	
т.	Maximum Temperature for Soldering	300		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PTA26N70	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	1.62	20.22
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	℃ /W



Electrical Characteristics

OFF Characteristics T_J =25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	700			٧	V _{GS} =0V, I _D =250uA
-	I _{DSS} Drain-to-Source Leakage Current			1	uA	V _{DS} =700V, V _{GS} =0V
IDSS				125		V _{DS} =560V, V _{GS} =0V, T _J =125℃
I _{GSS}	Gate-to-Source Leakage Current			+100	nA	V _{GS} =+30V, V _{DS} =0V
				-100	ПА	V _{GS} =-30V, V _{DS} =0V

ON Characteristics

T_J =25 °C unless otherwise specified

Tr endradionetro				1,	, 2000	anicoo ounci wioc opcomed
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance		350	450	mΩ	V _{GS} =10V, I _D =13A
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$, $I_{D}=250uA$
g FS	Forward Transconductance		32		S	V _{DS} =25V, I _D =13A

Dynamic Characteristics

Essentially independent of operating temperature

,					, 	ident of operating temperature
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		4.20		nF	V_{GS} =0V, V_{DS} =25V, f=1.0MH _Z
C _{rss}	Reverse Transfer Capacitance		0.20			
C _{oss}	Output Capacitance		1.40			
Q_g	Total Gate Charge		78			
Q_{gs}	Gate-to-Source Charge		21		nC	V_{DD} =350V, I_{D} =26A, V_{GS} =0 to 10V
Q_{gd}	Gate-to-Drain (Miller) Charge		20			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		32			
trise	Rise Time		65			V _{DD} =350V, I _D =13A,
td(OFF)	Turn-Off Delay Time		57		nS	V _{GS} = 10V R _G =10Ω
t fall	Fall Time		66			



Source-Drain Body Diode Characteristics

 T_J =25 $^{\circ}$ C unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[2]			26	۸	Integral PN-diode in
I _{SM}	Pulsed Source Current ^[2]			104	Α	MOSFET
V _{SD}	Diode Forward Voltage			1.5	V	I _S =26A, V _{GS} =0V
trr	Reverse recovery time		630		ns	V _{GS} =0V ,I _F =26A,
Qrr	Reverse recovery charge		6.0		uC	dir/dt=100A/μs

Note:

^[1] T_J=+25 $^{\circ}$ C to +150 $^{\circ}$ C .

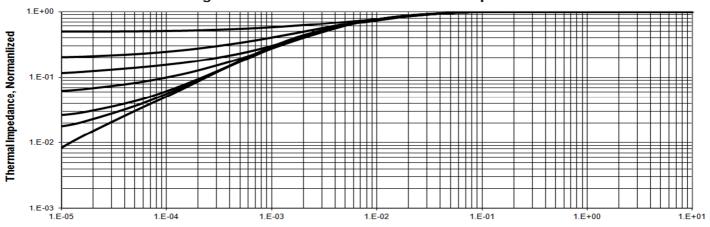
^[2] Silicon limited current only.

^[2] Silicon inflitted current only.
[3] Package limited current.
[4] Repetitive rating; pulse width limited by maximum junction temperature.
[5] Pulse width≤380µs; duty cycle≤2%.



Typical Characteristics

Figure 1. Maximum Transient Thermal Impedance



Rectangular Pulse Duration, Seconds

Figure 2. Max. Power Dissipation vs Case Temperature

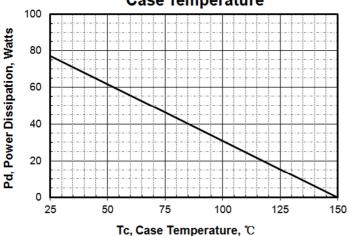


Figure 3 .Maximum Continuous Drain
Current vs Tc

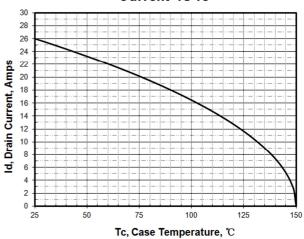


Figure 4. Output Characteristics

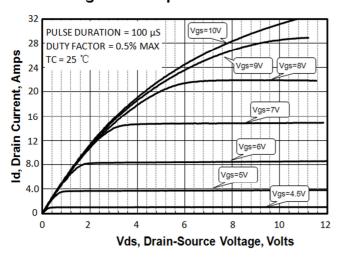
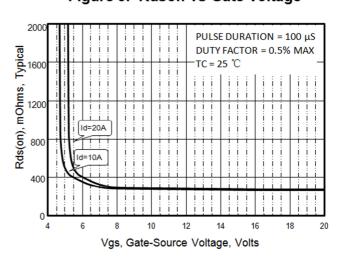


Figure 5. Rdson vs Gate Voltage





Typical Characteristics(Cont.)



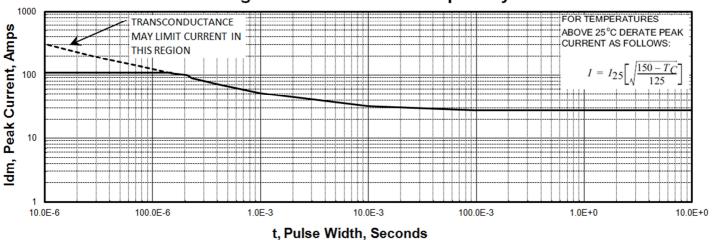


Figure 7. Transfer Characteristics

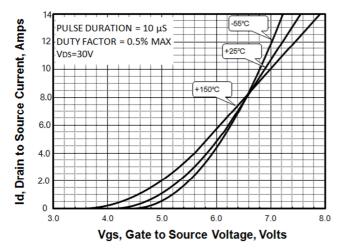


Figure 8. Unclamped Inductive Switching Capability

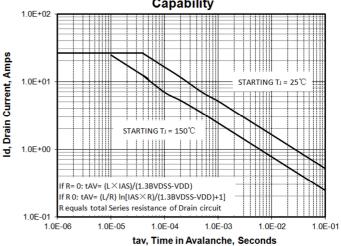


Figure 9. Drain to Source ON **Resistance vs Drain Current**

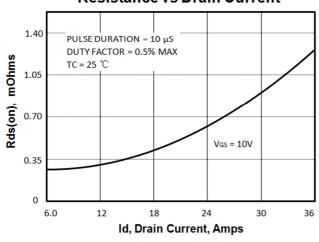
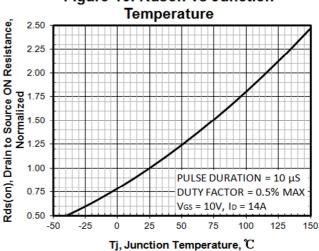


Figure 10. Rdson vs Junction





Typical Characteristics(Cont.)

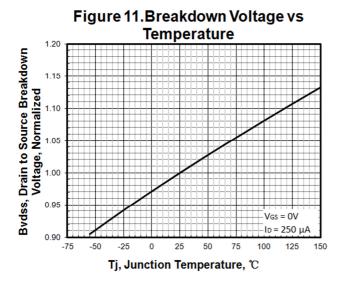


Figure 13 . Maximum Safe Operating Area

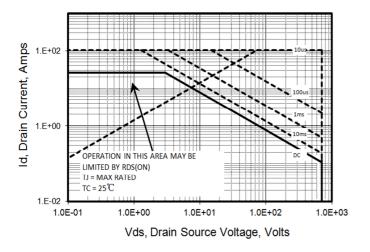


Figure 15 . Typical Gate Charge

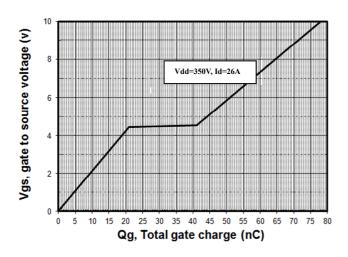


Figure 12. Threshold Voltage vs
Temperature

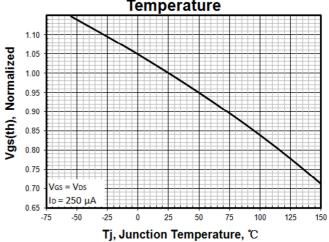


Figure 14. Capacitance vs Vds

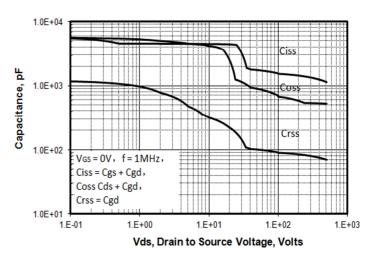
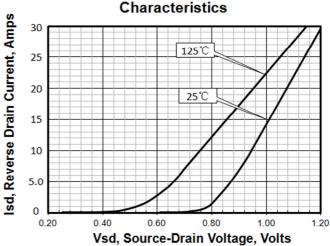


Figure 16.Body Diode Transfer Characteristics





Test Circuits and Waveforms

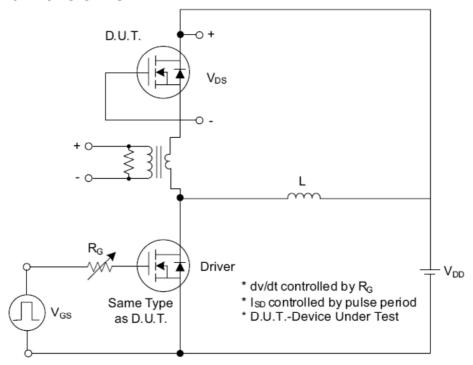


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

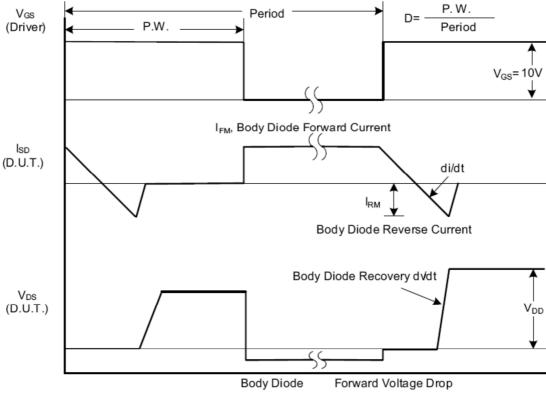


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms



Test Circuits and Waveforms (Cont.)

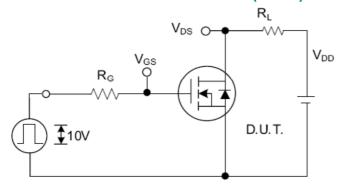


Fig. 2.1 Switching Test Circuit

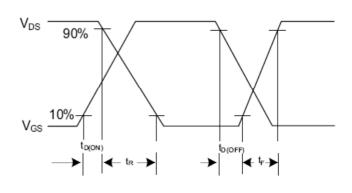


Fig. 2.2 Switching Waveforms

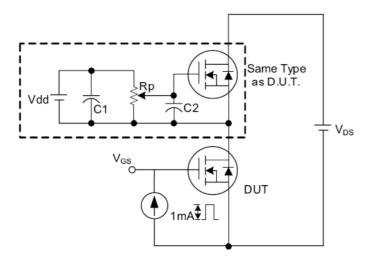


Fig. 3 . 1 Gate Charge Test Circuit

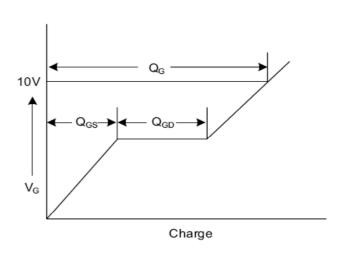


Fig. 3.2 Gate Charge Waveform

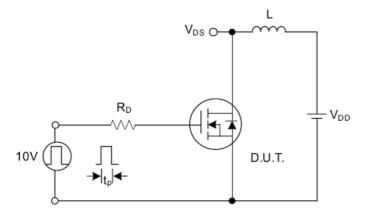


Fig. 4.1 Unclamped Inductive Switching Test Circuit

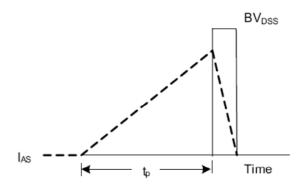


Fig. 4.2 Unclamped Inductive Switching Waveforms



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